## Notice of References Cited Application/Control No. 10/653,325 Examiner Blessing M. Fubara Applicant(s)/Patent Under Reexamination GRAFF ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	· Name	Classification
	Α	US-6,180,143	01-2001	Rapp et al.	426/3
	В	US-6,183,775	02-2001	Ventouras, Kimon	424/465
	С	US-6,290,985	09-2001	Ream et al.	424/440
	D	US-2003/0017202	01-2003	Bunick et al.	424/474
	Ε	US-5,733,574	03-1998	Dam, Anders	424/464
	F	US-6,139,864	10-2000	Durr et al.	424/439
	G	US-6,270,804	08-2001	Getz et al.	424/490
	Н	US-6,280,761	08-2001	Santus, Gian Carlo	424/435
	1	US-			
	J	US-			
	κ	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q			· · · ·		
	R			•	·	-
	S	-				
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	>	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.